## Features

- Typ.  $R_{DS(on)} = 33 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$ Typ.  $R_{DS(on)} = 45 \text{ m}\Omega @ V_{GS} = 15 \text{ V}$
- Ultra Low Gate Charge ( $Q_{G(tot)} = 105 \text{ nC}$ )
- High Speed Switching with Low Capacitance ( $C_{oss} = 162 \text{ pF}$ )
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

## **Typical Applications**

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Param	Parameter Symbol Val					
Drain to Source Voltage	Э		V <sub>DSS</sub>	650	V	
Gate to Source Voltage	1		V <sub>GS</sub>	8/+22	V	
Recommended Operatio of Gate to Source Volta		T <sub>C</sub> < 175°C – –	V <sub>GSop</sub>	5/+18	V	
Continuous Drain Current (Note 2)	Steady State	$T_C = 25^{\circ}C$	Ι <sub>D</sub>	55	A	
Power Dissipation (Note 2)	1		PD	187	W	
Continuous Drain Current (Notes 1, 2)	Steady State	$T_C = 100^{\circ}C$	Ι <sub>D</sub>	39	A	
Power Dissipation (Notes 1, 2)	1		P <sub>D</sub>	94	W	
Pulsed Drain Current (Note 3)	Т <sub>С</sub>	= 25°C	I <sub>DM</sub>	197	A	
Single Pulse Surge Drain Current Capability	$T_A = 25^{\circ}$ $R_G$	PC, t <sub>p</sub> = 10 μs, = 4.7 Ω	I <sub>DSC</sub>	315	A	
Operating Junction and S Range	Storage Te	emperature	T <sub>J</sub> , T <sub>stg</sub>	55 to +175	°C	
Source Current (Body Di	ode)		ا <sub>S</sub>	45	А	
Single Pulse Drain to S Energy ( $I_{L(pk)} = 12 \text{ A}, L =$	ource Ava = 1 mH) (N	alanche lote 4)	-E <sub>AS</sub> 72		mJ	
Maximum Lead Tempera (1/8" from case for 5 s)	iture for S	oldering	ΤL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

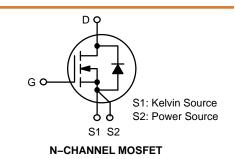
1. JA is constant value to follow guide table of LV/HV discrete final datasheet generation.

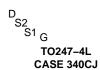
 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
Repetitive rating, limited by max junction temperature.

4. EAS of 72 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 12$  A,  $V_{DD} = 50$  V,  $V_{GS} = 18$  V.

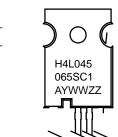
DATA SHEET www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
650 V	50 mΩ @ 18 V	55 A





MARKING DIAGRAM



H4L045065SC1 = Specific Device Code

- A = Assembly Location
- Y = Year
- WW = Work Week
- ZZ = Lot Traceability

### **ORDERING INFORMATION**

Device	Package	Shipping	
NVH4L045N065SC1	TO247 4L	30 Units / Tube	

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Мах	Unit
Junction to Case Steady State (Note 2)	$R_{ ext{ heta}JC}$	0.8	°C/W
Junction to Ambient Steady State (Notes-1, 2) -	$R_{\thetaJA}$	40	

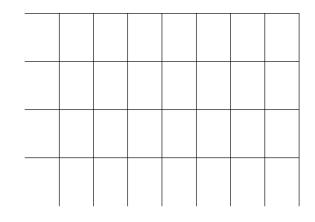
# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter Syn		Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 1 mA				

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified) (continued)

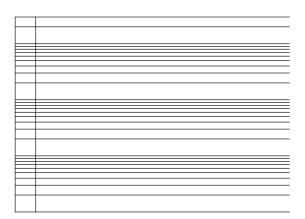
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS					
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 5/18 \text{ V}, I_{SD} = 25 \text{ A},$	-	20		ns –
Reverse Recovery Charge	Q <sub>RR</sub>	dl <sub>S</sub> /dt = 1000 A/μs		108		nC –
Reverse Recovery Energy	E <sub>REC</sub>		•	-		

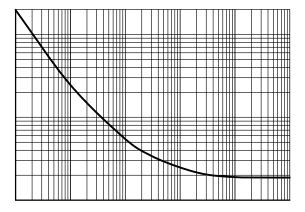
# **TYPICAL CHARACTERISTICS**



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# TYPICAL CHARACTERISTICS (continued)





## TYPICAL CHARACTERISTICS (continued)

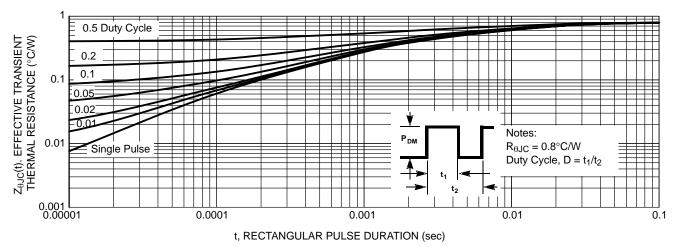


Figure 13. Junction-to-Case Thermal Response

			TO-247-4LD CASE 340CJ ISSUE A			DATE 16 SEP 2019
A	E	A	B A2	E1	Øp1 D2	
E/2		Q D	Ø		D1	
b2 b1 (3X)		L	L1 A1			
1 e1 ⊕ 0.254		4 b(4X)	С			

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